



**FEATURES**

- Circular active area
- Ideal for 193-400 nm detection
- 100% internal QE
- No cap for maximum responsivity
- Sacrificial cap taped on for shipping purposes

Dimensions are in inch [metric] units.

**ELECTRO-OPTICAL CHARACTERISTICS AT 25°C**

PARAMETERS	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Active Area	Ø 4.1 mm		13.2		mm <sup>2</sup>
Responsivity, $\mathcal{R}$	@ 254 nm	0.105	0.115	0.125	A/W
Shunt Resistance	$V_F = \pm 10$ mV	100	1000		Mohm
Reverse Breakdown Voltage, $V_R$	$I_R = 1$ $\mu$ A		9		Volts
Capacitance, C	$V_R = 0$ V		3	7	nF
Rise Time	$V_R = 0$ V			4	$\mu$ sec

**THERMAL PARAMETERS**

STORAGE AND OPERATING TEMPERATURE RANGE	
Storage Temperature Range	-20° TO 80°C
Maximum Junction Temperature	80°C
Lead Soldering Temperature <sup>1</sup>	240°C

<sup>1</sup>0.0625" from case for 10 seconds.

Shipped with temporary cover to protect photodiode and wire bond.  
Review Opto Diode "Handling Precautions for IRD Detectors" prior to removing cover.

